Search Notes

Application/Control No.	Applicant(s)/Patent Under Reexamination
10680205	ADACHI ET AL.
Examiner	Art Unit
Patel, Jayesh A	2624

SEARCHED				
Class	Subclass	Date	Examiner	
382	233,239246,250,298,299,	09/19/2007	JP	

SEARCH NOTES			
Search Notes	Date	Examiner	
See attached East Search History	09/19/2007	JP	
Consulted with Wenpeng on the allowable subject matter for claims 11-13.	09/13/07	JP	
Consulted with SPE Jingge Wu regarding the Claims. Also consulted with SPE Brian Werner regarding the 101 tied to. Brian advised that it is inherent tied to. Claim 13 is 112 possession problem.	12/11/2008	JP	
Consulted with Wenpeng regarding making a final with Karczewicz reference	06/29/2009	JP	
Consulted with SPE Matt Bella on defective 131 and making a nonfinal with the same reference	1/15/10	JP	
See the attached East.	08/10/2010	JP	
Consulted with SPE Samir regarding the allowance. See attached East, IEEE and Inventor serach. Also see the intereference search ((interleav\$3 or alternat\$3) and (dct or (transform adj coefficient\$1)) and inverse and (combining or joining) and (string\$1 or line\$1)).clm.	11/19/2010	JP	

INTERFERENCE SEARCH				
Class	Subclass	Date	Examiner	
382	233,239246,250,298,299,	04/09/08	JP	
PGPUB text search please see interference search printout				

/J. A. P./ Examiner.Art Unit 2624	

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